Power MOSFET 9.0 A, 60 V

N-Channel DPAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Features

• Pb-Free Packages are Available

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	60	Vdc
Drain-to-Gate Voltage ($R_{GS} = 10 \text{ M}\Omega$)	V_{DGR}	60	Vdc
Gate–to–Source Voltage – Continuous – Non–repetitive (t _p ≤10 ms)	V _{GS} V _{GS}	±20 ±30	Vdc
Drain Current - Continuous @ $T_A = 25^{\circ}C$ - Continuous @ $T_A = 100^{\circ}C$ - Single Pulse $(t_p \le 10 \ \mu s)$	I _D I _D	9.0 3.0 27	Adc Apk
Total Power Dissipation @ T _A = 25°C Derate above 25°C Total Power Dissipation @ T _A = 25°C (Note 1) Total Power Dissipation @ T _A = 25°C (Note 2)	P _D	28.8 0.19 2.1 1.5	W W/°C W W
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 175	°C
$\label{eq:single-pulse-prain-to-Source Avalanche} \begin{split} &\text{Single Pulse Drain-to-Source Avalanche} \\ &\text{Energy - Starting T}_{J} = 25^{\circ}\text{C} \\ &(\text{V}_{DD} = 25 \text{ Vdc, V}_{GS} = 10 \text{ Vdc,} \\ &\text{L} = 1.0 \text{ mH, I}_{L}(\text{pk}) = 7.75 \text{ A, V}_{DS} = 60 \text{ Vdc)} \end{split}$	E _{AS}	30	mJ
Thermal Resistance - Junction-to-Case - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	R _{θJC} R _{θJA} R _{θJA}	5.2 71.4 100	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

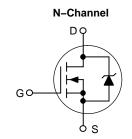
- 1. When surface mounted to an FR4 board using 0.5 sq in pad size.
- When surface mounted to an FR4 board using minimum recommended pad size.



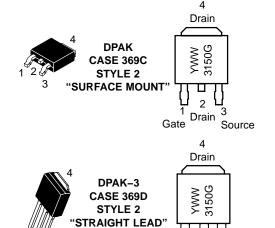
ON Semiconductor®

http://onsemi.com

9.0 AMPERES, 60 VOLTS $R_{DS(on)} = 122 \text{ m}\Omega \text{ (Typ)}$



MARKING DIAGRAMS



 3150
 = Device Code

 Y
 = Year

 WW
 = Work Week

 G
 = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

Gate Drain Source

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

OFF CHARACTERISTICS Drain-to-Source Breakdown Voltage (Note 3) (VGS = 0 VdC), lp = 250 µAcc) Temperature Coefficient (Positive) V(BRIDSS	Characteristic		Symbol	Min	Тур	Max	Unit
(V _{CS} = 0 Vdc, I _D = 250 μAdc) Total (Positive) Total (Positi	OFF CHARACTERISTICS				1	I.	<u>-1</u>
	Drain-to-Source Breakdown Voltage (Note 3) (V _{GS} = 0 Vdc, I _D = 250 μAdc)		V _{(BR)DSS}		_ 70.2		
ON CHARACTERISTICS (Note 3)	$(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$		I _{DSS}	- -	_ _		μAdc
Gate Threshold Voltage (Note 3) (V _{SS} = V _{SS} , I _p = 250 μAdc) Threshold Temperature Coefficient (Negative) 2.0 3.0 4.0 mV/°C	Gate-Body Leakage Current (V	$V_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc}$	I _{GSS}	-	-	±100	nAdc
V _{DS} = V _{GS} , I _D = 250 μAcc) C _{DS} = 10 Vdc, I _D = 4.5 Adc) C _{DS} = 10 Vdc, I _D = 4.5 Adc) C _{DS} = 10 Vdc, I _D = 4.5 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 3.0 Adc) C _{DS} = 10 Vdc, I _D = 4.5 Adc, T _J = 150°C) C _{DS} = 1.1.4	ON CHARACTERISTICS (Note	3)		•	•	•	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$(V_{DS} = V_{GS}, I_{D} = 250 \mu Adc)$,	$V_{GS(th)}$	2.0		4.0 _	
		sistance (Note 3)	R _{DS(on)}	_	122	150	mΩ
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	(V _{GS} = 10 Vdc, I _D = 9.0 Adc)		V _{DS(on)}	_ _			Vdc
$ \begin{array}{ c c c c } \hline \text{Input Capacitance} \\ \hline \text{Output Capacitance} \\ \hline \text{Output Capacitance} \\ \hline \text{Transfer Capacitance} \\ \hline \hline \text{Transfer Capacitance} \\ \hline \hline \text{Witching Characteristics} \\ \hline \hline \text{Ciss} \\ \hline \text{Ciss} \\$	Forward Transconductance (No	ote 3) (V _{DS} = 7.0 Vdc, I _D = 6.0 Adc)	9FS	-	5.4	_	mhos
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	DYNAMIC CHARACTERISTICS	1					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance		C_{iss}	_	200	280	pF
	Output Capacitance		C _{oss}	-	70	100	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Transfer Capacitance	,	C _{rss}	_	26	40	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	SWITCHING CHARACTERISTIC	CS (Note 4)					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time		t _{d(on)}	-	11.2	25	ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time		t _r	-	37.1	80	
	Turn-Off Delay Time		t _{d(off)}	-	12.2	25]
	Fall Time		t _f	_	23	50]
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Charge		Q _T	_	7.1	15	nC
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			Q ₁	_	1.7	_]
		i gg i e i asy (note sy	Q ₂	_	3.5	_	
	SOURCE-DRAIN DIODE CHAR	RACTERISTICS					
	Forward On-Voltage	$(I_S = 19 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J =$	V _{SD}			1.20 –	Vdc
$dI_{S}/dt = 100 \text{ A/}\mu\text{s}) \text{ (Note 3)} \qquad \qquad t_{b} \qquad - \qquad 7.3 \qquad -$			t _{rr}	-	28.9	_	ns
t _b - 7.3 -		$(I_S = 9.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/us}) \text{ (Note 3)}$	ta	_	21.6	_	
Reverse Recovery Stored Charge Q _{RR} - 0.036 - μC	415/41 = 100 / VRO) (NOICO)		t _b	-	7.3	_]
	Reverse Recovery Stored Char	ge	Q_{RR}	_	0.036	_	μC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

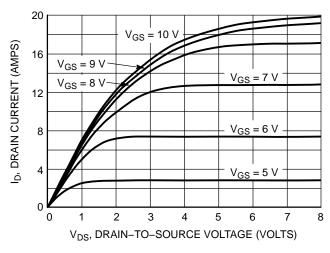


Figure 1. On-Region Characteristics

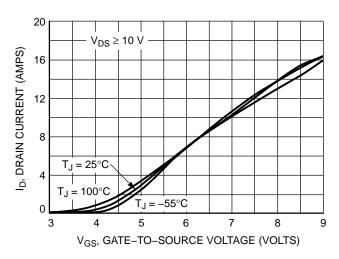


Figure 2. Transfer Characteristics

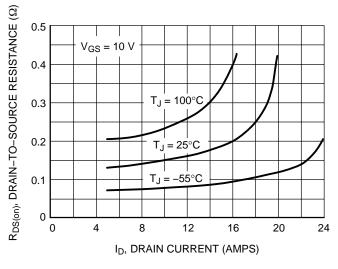


Figure 3. On–Resistance versus Gate–To–Source Voltage

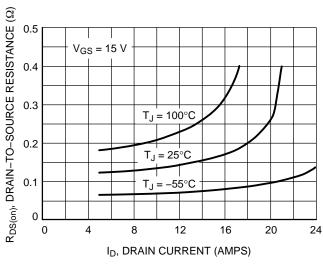


Figure 4. On-Resistance versus Drain Current and Gate Voltage

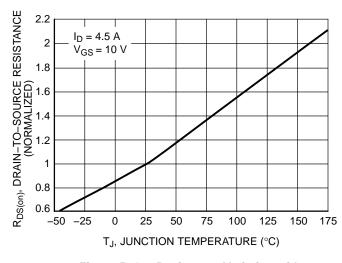


Figure 5. On–Resistance Variation with Temperature

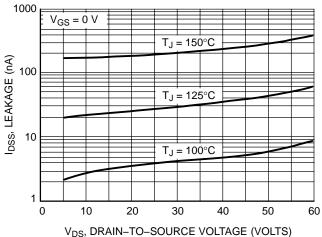


Figure 6. Drain-To-Source Leakage Current versus Voltage

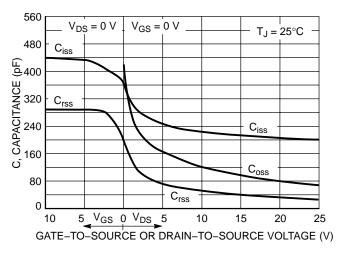


Figure 7. Capacitance Variation

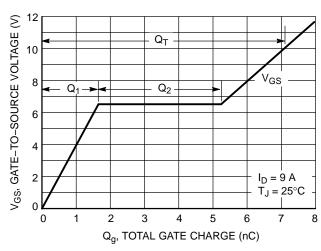


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

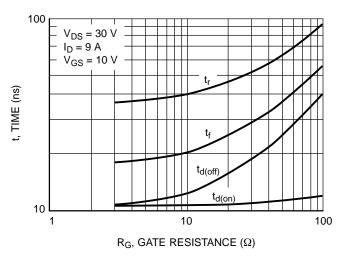


Figure 9. Resistive Switching Time Variation versus Gate Resistance

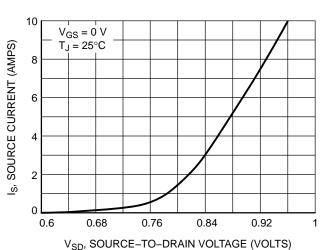


Figure 10. Diode Forward Voltage versus Current

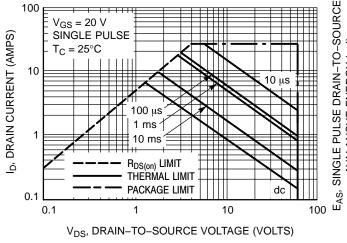


Figure 11. Maximum Rated Forward Biased Safe Operating Area

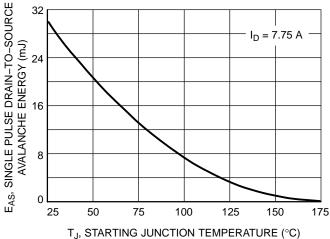


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

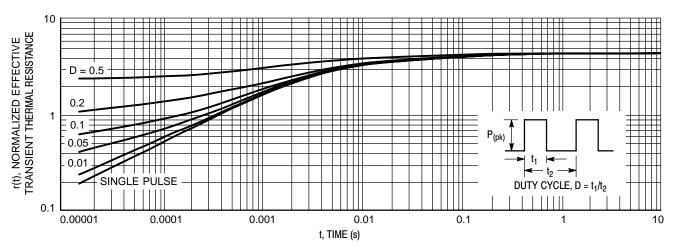


Figure 13. Thermal Response

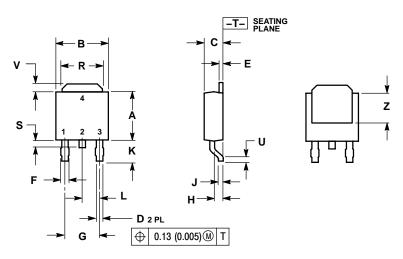
ORDERING INFORMATION

Device	Package	Shipping [†]
NTD3055-150	DPAK	75 Units/Rail
NTD3055-150G	DPAK (Pb-Free)	75 Units/Rail
NTD3055-150-1	DPAK-3	75 Units/Rail
NTD3055-150-1G	DPAK-3 (Pb-Free)	75 Units/Rail
NTD3055-150T4	DPAK	2500 Tape & Reel
NTD3055-150T4G	DPAK (Pb-Free)	2500 Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

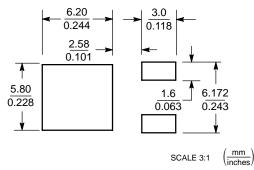
DPAK CASE 369C-01 ISSUE O



	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

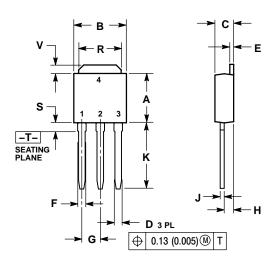
SOLDERING FOOTPRINT*

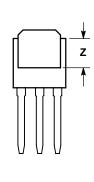


*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

DPAK-3 CASE 369D-01 ISSUE B





NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87 1.0	
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE

- 2. DRAIN
- 3. SOURCE DRAIN

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